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	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/761,281	YIP ET AL.	
	Examiner	Art Unit	
_	Afsar M. Qureshi	2667	

			
SEARCHED			
Class	Subclass	Date	Examiner
370	392	8/19/2005	AQ
	295.32		
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